Photocouplers Infrared LED & Photo Transistor

TLP290-4

1. Applications

- Programmable Logic Controllers (PLCs)
- Switching Power Supplies
- Simplex/Multiplex Data Transmission

2. General

The Toshiba TLP290-4 consists of phototransistors optically coupled to an infrared LED. The TLP290-4 Photocoupler is housed in the very small and thin SO16 package.

Since the TLP290-4 is guaranteed over a wide operating temperature range ($T_a = -55$ to 110 °C), it is suitable for high-density surface mount applications such as programmable controllers.

3. Features

- (1) Collector-emitter voltage: 80 V (min)
- (2) Current transfer ratio: 50 % (min) GB Rank: 100 % (min)
- (3) Isolation voltage: 2500 Vrms (min)
- (4) Operating temperature: -55 to 110 °C
- (5) Safety standards

UL-recognized: UL 1577, File No.E67349

cUL-recognized: CSA Component Acceptance Service No.5A File No.E67349

VDE-approved: EN 60747-5-5 (Note 1)

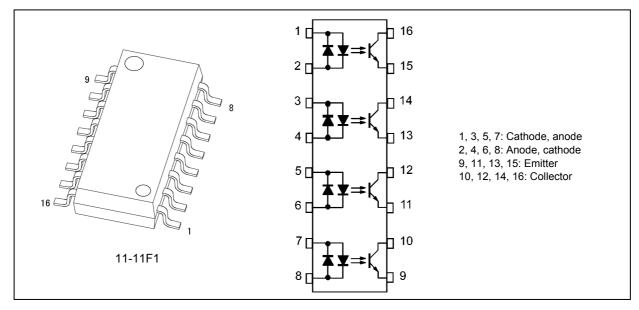
CQC-approved: GB4943.1, GB8898 Thailand Factory $% \mathcal{G} = \mathcal{G} = \mathcal{G} = \mathcal{G} = \mathcal{G} = \mathcal{G}$



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Note 1: When a VDE approved type is needed, please designate the Option (V4).

4. Packaging and Pin Assignment



Start of commercial production 2012-03 2019-11-29 Rev.7.0

5. Principle of Operation

5.1. Mechanical Parameters

Characteristics	Min	Unit
Creepage distances	5.0	mm
Clearance	5.0	
Internal isolation thickness	0.1	

6. Absolute Maximum Ratings (Note) (Unless otherwise specified, $T_a = 25$ °C)

	Characteristics		Symbol	Note	Rating	Unit
LED	R.M.S. forward current		I _{F(RMS)}		±50	mA
	Input forward current derating	(T _a ≥ 50 °C)	$\Delta I_F / \Delta T_a$		-0.67	mA/°C
	Input forward current (pulsed)		I _{FP}	(Note 1)	±1	A
	Input power dissipation		PD		70	mW
	Input power dissipation derating (1 circuit)	$(T_a \ge 50 \ ^\circ C)$	$\Delta P_D / \Delta T_a$		-0.93	mW/°C
	Junction temperature		Тj		125	°C
Detector	Collector-emitter voltage		V _{CEO}		80	V
	Emitter-collector voltage		V _{ECO}		7	
	Collector current		Ι _C		50	mA
	Collector power dissipation		Pc		100	mW
	Collector power dissipation derating (1 circuit)	$(T_a \ge 25 \ ^\circ C)$	$\Delta P_{C} / \Delta T_{a}$		-1.0	mW/°C
	Junction temperature		Тj		125	°C
Common	Operating temperature		T _{opr}		-55 to 110	°C
	Storage temperature		T _{stg}		-55 to 125	
	Lead soldering temperature	(10 s)	T _{sol}		260	
	Total power dissipation (1 circuit)		P _T		170	mW
	Isolation voltage	(AC, 60 s, R.H. ≤ 60 %)	BV _S	(Note 2)	2500	Vrms

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Note 1: Pulse width (PW) \leq 100 $\mu s,\,f$ = 100 Hz

Note 2: This device is considered as a two-terminal device: All pins on the LED side are shorted together, and all pin on the photodetector side are shorted together.

7. Electrical Characteristics (Unless otherwise specified, $T_a = 25$ °C)

	Characteristics	Symbol	Note	Test Condition	Min	Тур.	Max	Unit
LED	Input forward voltage	V _F		I _F = ±10 mA	1.1	1.20	1.4	V
	Input capacitance	Ct		V = 0 V, f = 1 MHz		30	—	pF
Detector	Collector-emitter breakdown voltage	V _{(BR)CEO}		I _C = 0.5 mA	80		_	V
	Emitter-collector breakdown voltage	V _{(BR)ECO}		I _E = 0.1 mA	7		_	
	Dark Current	I _{DARK}		V _{CE} = 48 V		0.01	0.1	μA
				V _{CE} = 48 V, T _a = 85 °C		2	50	
	Collector-emitter capacitance	C _{CE}		V = 0 V, f = 1 MHz		10	_	pF

8. Coupled Electrical Characteristics (Unless otherwise specified, $T_a = 25$ °C)

Characteristics	Symbol	Note	Test Condition	Min	Тур.	Max	Unit
Current transfer ratio	I _C /I _F	(Note 1)	I_F = ±5 mA, V _{CE} = 5 V	50	_	400	%
			I_F = ±5 mA, V _{CE} = 5 V, Rank GB	100	_	400	
Saturated current transfer ratio	I _C /I _{F(sat)}		I_F = ±1 mA, V_{CE} = 0.4 V	—	60	_	
			I_F = ±1 mA, V_{CE} = 0.4 V, Rank GB	30	—	_	
Collector-emitter saturation	V _{CE(sat)}		I _C = 2.4 mA, I _F = ±8 mA	_	—	0.4	V
voltage			I _C = 0.2 mA, I _F = ±1 mA	_	0.2	—	
			I_{C} = 0.2 mA, I_{F} = \pm 1 mA, Rank GB	_	—	0.4	
OFF-state collector current	I _{C(off)}		$V_{F} = \pm 0.7 V, V_{CE} = 48 V$		_	10	μA
Collector current ratio	I _C (ratio)		See Fig. 8.1. I _C (I _F = -5 mA)/I _C (I _F = 5 mA)	0.33	—	3	_

Note 1: See Table 8.1 for current transfer ratio.

Table 8.1 Current transfer ratio (CTR) Rank (Note) (Unless otherwise specified, Ta = 25 °C)

Rank	Test Condition	Current transfer ratio I _C /I _F Min	Current transfer ratio I _C /I _F Max	Marking of Classification	Unit
Blank	I_F = ±5 mA, V_{CE} = 5 V	50	400	Blank, GB	%
GB		100	400	GB	

Note: Specify both the part number and a rank in this format when ordering. Example: TLP290-4(GB,E

For safety standard certification, however, specify the part number alone. Example: TLP290-4(GB,E: TLP290-4

$$I_{C(ratio)} = \frac{I_{C2}(I_F = I_{F2}, V_{CE} = 5V)}{I_{C1}(I_F = I_{F1}, V_{CE} = 5V)}$$

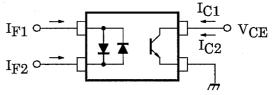


Fig. 8.1 Collector Current Ratio Test Circuit

9. Isolation Characteristics (Unless otherwise specified, T_a = 25 °C)

Characteristics	Symbol	Note	Test Conditions	Min	Тур.	Max	Unit
Total capacitance (input to output)	Cs	(Note 1)	V _S = 0 V, f = 1 MHz		0.8	—	pF
Isolation resistance	R _S	(Note 1)	V_S = 500 V, R.H. \leq 60 %	10 ¹²	1014	—	Ω
Isolation voltage	BVS	(Note 1)	AC, 60 s	2500	_	_	Vrms

Note 1: This device is considered as a two-terminal device: All pins on the LED side are shorted together, and all pin on the photodetector side are shorted together.

10. Switching Characteristics (Unless otherwise specified, Ta = 25 °C)

Characteristics	Symbol	Note	Test Condition	Min	Тур.	Max	Unit
Rise time	tr		V _{CC} = 10 V, I _C = 2 mA,	_	2	_	μS
Fall time	t _f		R _L = 100 Ω	_	3	—	
Turn-on time	t _{on}				3	_	
Turn-off time	t _{off}				3	_	
Turn-on time	t _{on}		See Figure 10.1	_	2	—	
Storage time	ts		R _L = 1.9 kΩ, V _{CC} = 5 V, I⊨ = 16 mA		25	_	
Turn-off time	t _{off}				60		

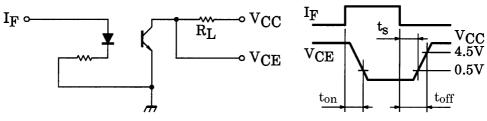
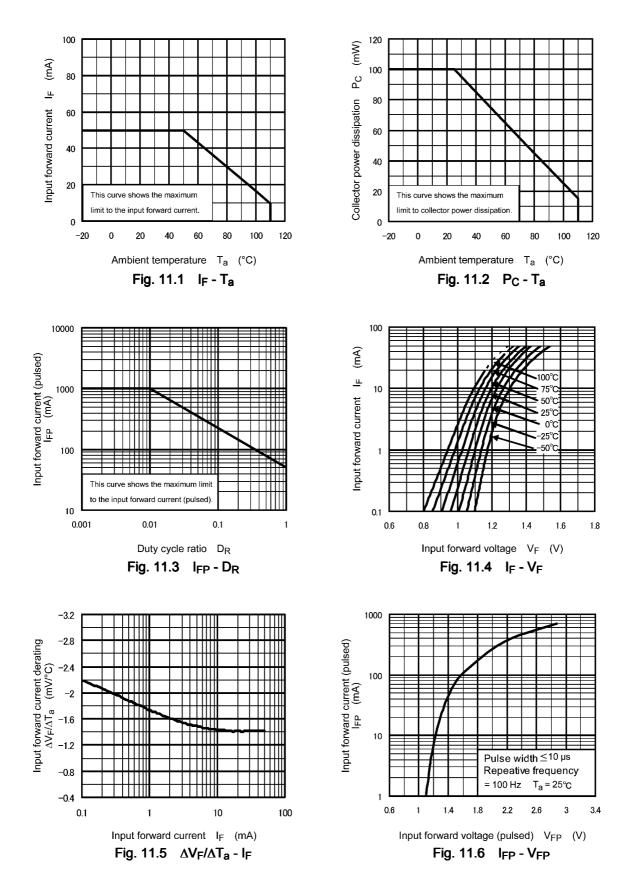
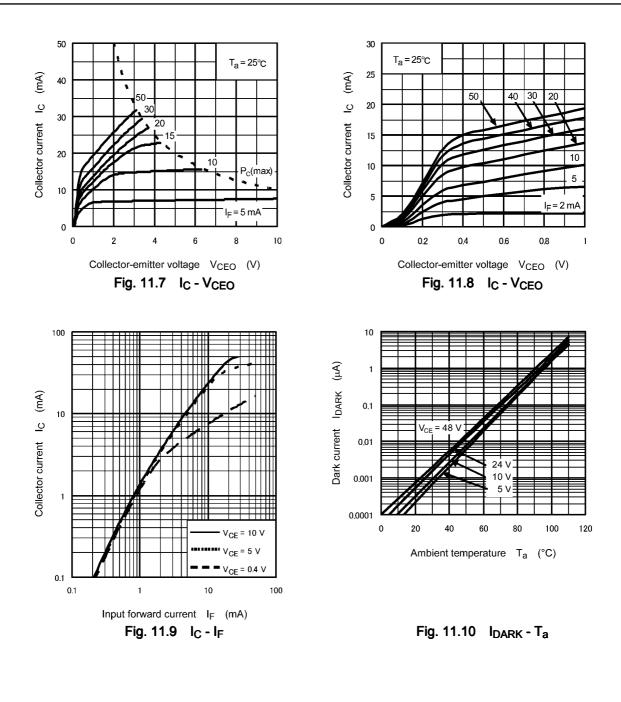
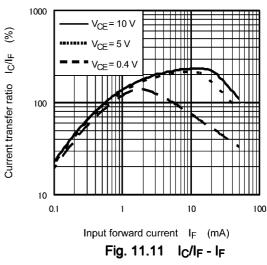


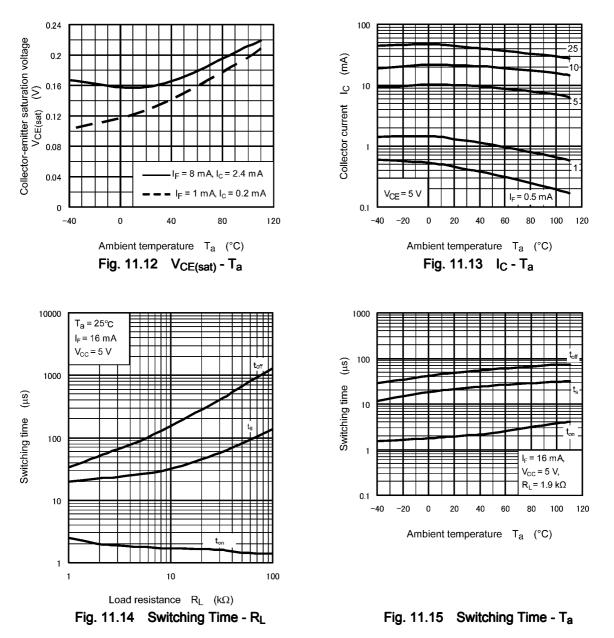
Fig. 10.1 Switching Time Test Circuit and Waveform

11. Characteristics Curves (Note)









Note: The above characteristics curves are presented for reference only and not guaranteed by production test, unless otherwise noted.

12. Soldering and Storage

12.1. Precautions for Soldering

The soldering temperature should be controlled as closely as possible to the conditions shown below, irrespective of whether a soldering iron or a reflow soldering method is used.

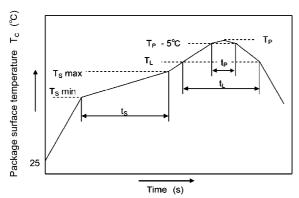
• When using soldering reflow.

The soldering temperature profile is based on the package surface temperature.

(See the figure shown below, which is based on the package surface temperature.)

Reflow soldering must be performed once or twice.

The mounting should be completed with the interval from the first to the last mountings being 2 weeks.



	Symbol	Min	Max	Unit
Preheat temperature	Ts	150	200	°C
Preheat time	ts	60	120	s
Ramp-up rate (T_L to T_P)			3	°C/s
Liquidus temperature	TL	2	17	°C
Time above T _L	tL	60	150	s
Peak temperature	Τ _Ρ		260	°C
Time during which T_c is between (T _P – 5) and T _P	t₽		30	s
Ramp-down rate $(T_P \text{ to } T_L)$			6	°C/s

An Example of a Temperature Profile When Lead(Pb)-Free Solder Is Used

• When using soldering flow

Preheat the device at a temperature of 150 °C (package surface temperature) for 60 to 120 seconds. Mounting condition of 260 °C within 10 seconds is recommended.

Flow soldering must be performed once.

When using soldering Iron

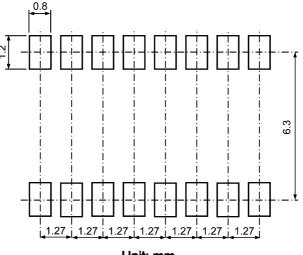
Complete soldering within 10 seconds for lead temperature not exceeding 260 °C or within 3 seconds not exceeding 350 °C

Heating by soldering iron must be done only once per lead.

12.2. Precautions for General Storage

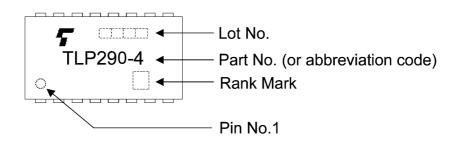
- Avoid storage locations where devices may be exposed to moisture or direct sunlight.
- Follow the precautions printed on the packing label of the device for transportation and storage.
- Keep the storage location temperature and humidity within a range of 5 °C to 35 °C and 45 % to 75 %, respectively.
- Do not store the products in locations with poisonous gases (especially corrosive gases) or in dusty conditions.
- Store the products in locations with minimal temperature fluctuations. Rapid temperature changes during storage can cause condensation, resulting in lead oxidation or corrosion, which will deteriorate the solderability of the leads.
- When restoring devices after removal from their packing, use anti-static containers.
- Do not allow loads to be applied directly to devices while they are in storage.
- If devices have been stored for more than two years under normal storage conditions, it is recommended that you check the leads for ease of soldering prior to use.

13. Land Pattern Dimensions (for reference only)



Unit: mm

14. Marking



15. Ordering Information

When placing an order, please specify the part number, CTR rank, tape type and quantity as shown in the following example.

Example) TLP290-4(GB-TP,E 2000 pcs

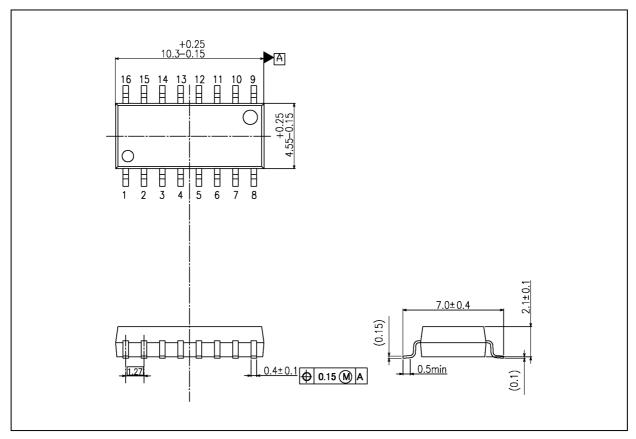
Part number: TLP290-4 CTR rank: (GB Tape type: TP [[G]]/RoHS COMPATIBLE: E **(Note 1)** Quantity (must be a multiple of 2000): 2000 pcs

Note 1: Please contact your Toshiba sales representative for details on environmental information such as the product's RoHS compatibility. RoHS is the Directive 2011/65/EU of the European Parliament and of the Council of 8 June 2011 on the restriction of the use of certain hazardous substances in electrical and electronic equipment.

TLP290-4

Package Dimensions

Unit: mm



Weight: 0.19 g (typ.)

	Package Name(s)
TOSHIBA: 11-11F1	

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